

Final Product/Process Change Notification Document #: FPCN21458Z

Issue Date: 25 October 2016

Title of Change:	Qualification of ON Semiconductor Carmona, Philippines as additional Final Test Location for NCV51510 products.
Proposed first ship date:	25 October 2017 or earlier after customer approval.
Contact information:	Contact your local ON Semiconductor Sales Office or <bett.lofts@onsemi.com></bett.lofts@onsemi.com>
Samples:	Contact your local ON Semiconductor Sales Office
Additional Reliability Data:	Contact your local ON Semiconductor Sales Office or <bett.lofts@onsemi.com>.</bett.lofts@onsemi.com>
Type of notification:	This is a Final Product/Process Change Notification (FPCN) sent to customers. FPCNs are issued 12months prior to implementation of the change or earlier upon customer approval.
	ON Semiconductor will consider this proposed change and its conditions acceptable, unless an inquiry is made in writing within 30 days of delivery of this notice. To do so, contact <pcn.support@onsemi.com>.</pcn.support@onsemi.com>
Change Part Identification:	No change to the device marking. Marking will continue to reflect the assembly site location.
Change category:	☐ Wafer Fab Change ☐ Assembly Change ☐ Test Change ☐ Other Test Location addition
Change Sub-Category(s): ☐ Manufacturing Site Change/Addition ☐ Manufacturing Process Change ☐ Product specific change ☐ Other: Test Location addition	
Sites Affected: All site(s) not ap	plicable ON Semiconductor site(s): ON Carmona, Philippines External Foundry/Subcon site(s)
Description and Purpose:	
This Final Notification announces to expand Final test capacity of ON Semiconductor Carmona, Philippines as an alternate test location for the NCV51510 family of parts.	
The same test platform, hardware and test program will be used as in the primary Malaysia test location.	
Product shipments from ON Semiconductor Carmona, Philippines will begin on 12 December 2016 or earlier upon customer approval.	
Electrical Characteristic Summary:	
Gauge R&R Results, Correlation study, Cpk results all meet the ON Semiconductor requirements. Reports available upon request.	
List of Affected Standard Parts:	
Part Number	
NCV51510MNTAG	
NCV51510MWTAG	

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